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# FAIRCHILD

SEMICONDUCTOR®

# FDS8813NZ N-Channel PowerTrench<sup>®</sup> MOSFET 30V, 18.5A, 4.5m $\Omega$

#### Features

- Max  $r_{DS(on)}$  = 4.5m $\Omega$  at V<sub>GS</sub> = 10V, I<sub>D</sub> = 18.5A
- Max  $r_{DS(on)} = 6.0 m\Omega$  at  $V_{GS} = 4.5 V$ ,  $I_D = 16 A$
- HBM ESD protection level of 5.6kV typical (note 3)
- High performance trench technology for extremely low r<sub>DS(on)</sub>
- High power and current handling capability
- RoHS compliant

### **General Description**

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench<sup>®</sup> process that has been especially tailored to minimize the on-state resistance.

This device is well suited for Power Management and load switching applications common in Notebook Computers and Portable Battery Packs.



## **MOSFET Maximum Ratings** $T_A = 25^{\circ}C$ unless otherwise noted

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| Symbol                            | Parameter  |           | Ratings     | Units |  |
|-----------------------------------|--|-----------|-------------|-------|--|
| V <sub>DS</sub>                   | Drain to Source Voltage                          |           | 30          | V     |  |
| V <sub>GS</sub>                   | Gate to Source Voltage                           |           | ±20         | V     |  |
| I <sub>D</sub>                    | Drain Current -Continuous                        | (Note 1a) | 18.5        | Α     |  |
|                                   | -Pulsed  |           | 74          |       |  |
| E <sub>AS</sub>                   | Single Pulse Avalanche Energy                    | (Note 4)  | 337         | mJ    |  |
| P <sub>D</sub>                    | Power Dissipation                                | (Note 1a) | 2.5         |       |  |
|                                   | Power Dissipation                                | (Note 1b) | 1.0         |       |  |
| T <sub>J</sub> , T <sub>STG</sub> | Operating and Storage Junction Temperature Range |           | -55 to +150 | °C    |  |

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#### **Thermal Characteristics**

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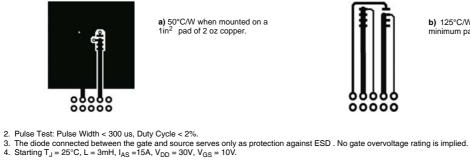
| $R_{	ext{	heta}JC}$   | Thermal Resistance, Junction to Case    | (Note 1)  | 25  |      |
|-----------------------|---|-----------|-----|------|
| $R_{\theta JA}$       | Thermal Resistance, Junction to Ambient | (Note 1a) | 50  | °C/W |
| $R_{	extsf{	heta}JA}$ | Thermal Resistance, Junction to Ambient | (Note 1b) | 125 |      |

#### Package Marking and Ordering Information

| Device Marking | Device    | Reel Size    | Tape Width | Quantity   |  |
|----------------|-----------|--------------|------------|------------|--|
| FDS8813NZ      | FDS8813NZ | DS8813NZ 13" |            | 2500 units |  |

| Symbol                               | Parameter   | Test Conditions  | Min      | Тур         | Max         | Units    |
|--------------------------------------|---|--|----------|-------------|-------------|----------|
| Off Chara                            | cteristics  |  |          |             | 1           | 1        |
| BV <sub>DSS</sub>                    | Drain to Source Breakdown Voltage                           | $I_{D} = 250 \mu A, V_{GS} = 0 V$  | 30       |             |             | V        |
| $\frac{\Delta BV_{DSS}}{\Delta T_J}$ | Breakdown Voltage Temperature<br>Coefficient                | $I_D = 250\mu$ A, referenced to 25°C   |          | 20          |             | mV/°0    |
| IDSS                                 | Zero Gate Voltage Drain Current                             | $V_{DS} = 24V, V_{GS} = 0V$  |          |             | 1           | μA       |
| I <sub>GSS</sub>                     | Gate to Source Leakage Current                              | $V_{GS} = \pm 20V, V_{DS} = 0V$  |          |             | ±10         | μA       |
| On Chara                             | cteristics (Note 2)   |  |          |             |             |          |
| V <sub>GS(th)</sub>                  | Gate to Source Threshold Voltage                            | $V_{GS} = V_{DS}, I_D = 250 \mu A$   | 1        | 1.8         | 3           | V        |
| $\Delta V_{GS(th)}$<br>$\Delta T_J$  | Gate to Source Threshold Voltage<br>Temperature Coefficient | $I_D = 250\mu A$ , referenced to 25°C  |          | -6          |             | mV/°0    |
| ΔIJ                                  |   | V <sub>GS</sub> = 10V, I <sub>D</sub> = 18.5A                                      |          | 3.8         | 4.5         |          |
|                                      |   | $V_{GS} = 4.5V, I_D = 16A$   |          | 4.7         | 6.0         |          |
| r <sub>DS(on)</sub>                  | Static Drain to Source On Resistance                        | $V_{GS} = 10V, I_D = 18.5A,$<br>T <sub>1</sub> = 125°C                             |          | 5.1         | 6.6         | mΩ       |
| 9 <sub>FS</sub>                      | Forward Transconductance                                    | $V_{DS} = 5V, I_{D} = 18.5A$   |          | 74          |             | S        |
|                                      | Input Capacitance Output Capacitance                        | $V_{DS} = 5V, T_D = 10.5A$<br>$V_{DS} = 15V, V_{GS} = 0V,$<br>f = 1MHz<br>f = 1MHz | <b>"</b> | 3115<br>580 | 4145<br>775 | pF<br>pF |
| C <sub>oss</sub>                     |   | -f = 1MHz  |          |             | 775         | pF       |
| C <sub>rss</sub>                     | Reverse Transfer Capacitance                                |  |          | 345         | 520         | pF       |
| R <sub>g</sub>                       | Gate Resistance   | T = 1MHZ   |          | 1.8         |             | Ω        |
| Switching                            | g Characteristics   |  |          |             |             |          |
| t <sub>d(on)</sub>                   | Turn-On Delay Time  |  |          | 13          | 24          | ns       |
| t <sub>r</sub>                       | Rise Time   | $V_{DD} = 15V, I_D = 18.5A$  |          | 8           | 16          | ns       |
| t <sub>d(off)</sub>                  | Turn-Off Delay Time   | $V_{GS} = 10V, R_{GEN} = 6\Omega$  |          | 39          | 63          | ns       |
| t <sub>f</sub>                       | Fall Time   |  |          | 7           | 14          | ns       |
| Q <sub>g</sub>                       | Total Gate Charge   | $V_{GS} = 0V \text{ to } 10V$ $V_{DD} = 15V$                                       |          | 55          | 76          | nC       |
| Qg                                   | Total Gate Charge   | $V_{GS} = 0V \text{ to } 5V$ $I_D = 18.5A$   |          | 28          | 40          | nC       |
| Q <sub>gs</sub>                      | Gate to Source Charge                                       |  |          | 9           |             | nC       |
| Q <sub>gd</sub>                      | Gate to Drain "Miller" Charge                               |  |          | 10          |             | nC       |
| *                                    | urce Diode Characteristics                                  | -  |          | I           |             |          |
| V <sub>SD</sub>                      | Source to Drain Diode Forward Voltage                       | $V_{GS} = 0V, I_S = 2.1A$ (Note 2)   |          | 0.7         | 1.2         | V        |
| t <sub>rr</sub>                      | Reverse Recovery Time                                       |  |          | 32          | 47          | ns       |
| Q <sub>rr</sub>                      | Reverse Recovery Charge                                     | —I <sub>F</sub> = 18.5A, di/dt = 100A/μs   |          | 27          | 41          | nC       |

pins.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta JA}$  is determined by the user's board design.

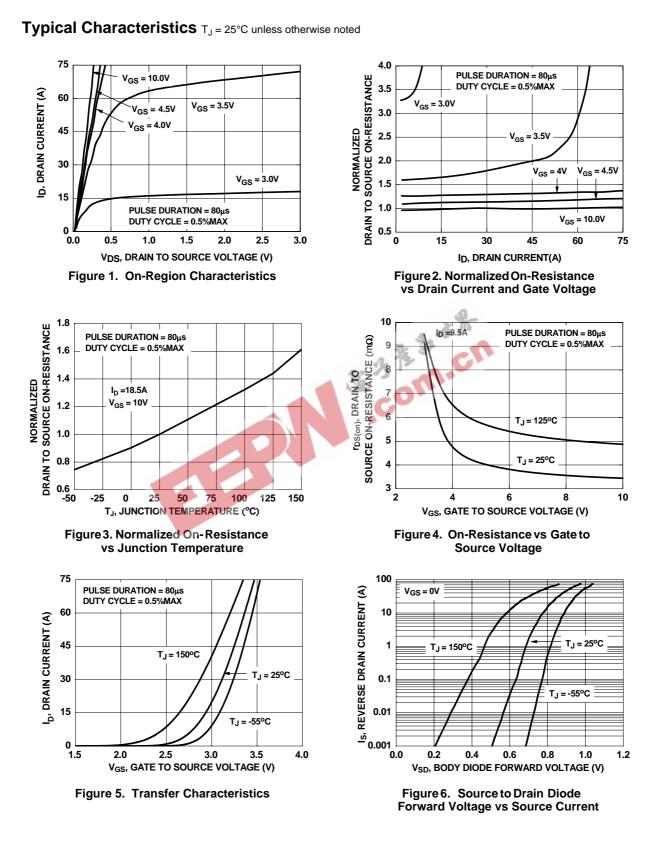


**a)** 50°C/W when mounted on a 1in<sup>2</sup> pad of 2 oz copper.



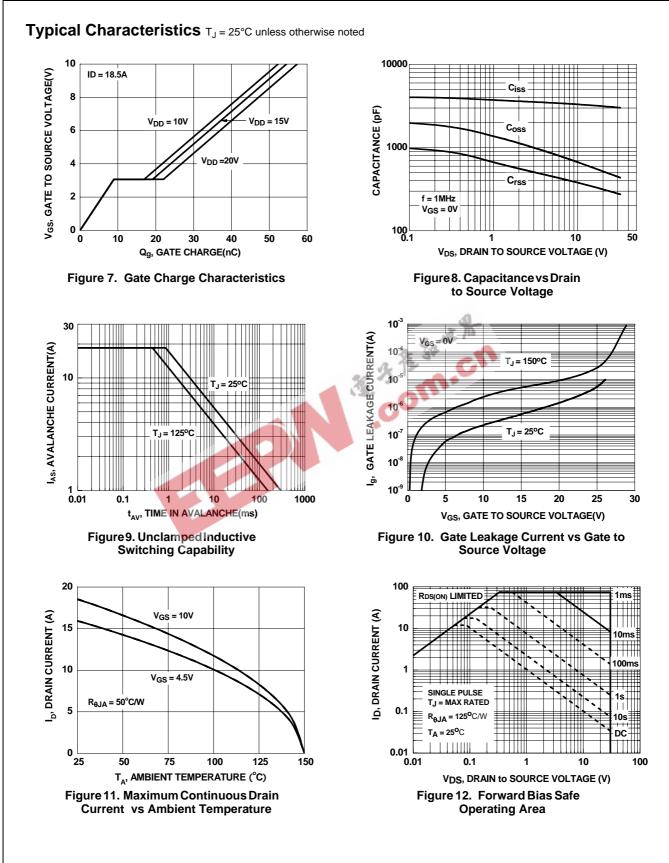
**b)** 125°C/W when mounted on a minimum pad .





FDS8813NZ Rev.C

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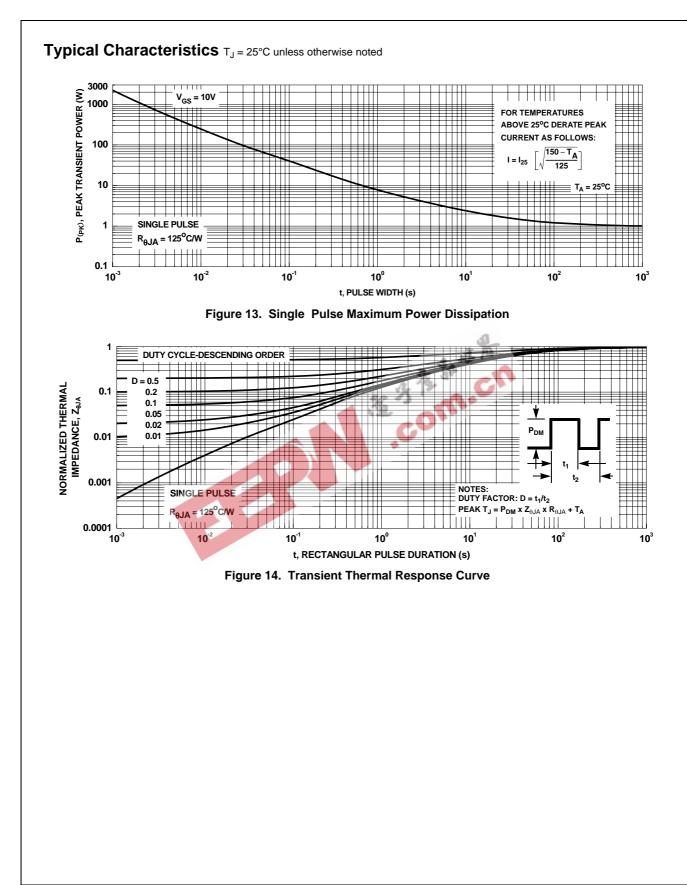


FDS8813NZ Rev.C

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